## Claims:

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- 1. An integrated circuit comprising: a gate array architecture; 1
- said gate array architecture including a semiconductor substrate having a plurality of N-type 2
- diffusion regions and P-type diffusion regions; said diffusion regions having partially overlying 3
- polysilicon landing sites to form N-type and P-type transistors; 4
- wherein the regions are relatively-sized to form two distinct fransistor sizes, smaller N- and 5
- P-type transistors and larger N- and P-type transistors. 6
- The integrated circuit of claim 1, wherein the ratio between the two distinct transistor sizes 2. 1
- is on the order of one-third. 2
  - The integrated circuit of claim 2, wherein the ratio between the capacitance of the larger 3. and smaller relatively sized transistors is on the order of one-third.
  - The integrated circuit of claim 1, wherein said partially overlying polysilicon landings for the 4. smaller and larger transistors are not connected.
  - The integrated circuit of claim 4, and further comprising an interconnect overlying said gate array architecture;

the interconnect being adapted to connect the transistors of the gate array architecture to form a flip-flop.

- The integrated circuit of claim 5, wherein the interconnect is further adapted to connect the transistors of the gate array architecture/so that the internal clock buffers of the flip-flop are formed from the smaller transistors.
- 1 2 3 The integrated circuit of claim 6, wherein said gate array architecture is repeated in said 1
- 2 integrated circuit.
- The integrated circuit of claim b, wherein said integrated circuit is incorporated in a 1
- communications device. 2
- The integrated circuit of claim 6, wherein said integrated circuit is attached to a 1 9.
- motherboard. 2
- The integrated circuit of claim 9, wherein said integrated circuit is in incorporated in a 1 10.
- 2 personal computer.
- The integrated circuit/of claim 10, wherein said personal computer comprises one of a 1 11.
- laptop and a desktop computer. 2
- The integrated cirouit of claim 1, wherein successive rows of small diffusion regions are 1 12.
- followed by successive fows of regular-sized diffusion regions; 2
- wherein immediately successive rows within similarly-sized diffusion regions have opposite 3.
- 4 polarity.



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13. A method of fabricating an integrated circuit chip comprising:

processing a semiconductor substrate to form a gate array architecture of transistors in the substrate, the gate array architecture comprising a plurality of N-type diffusion regions and P-type diffusion regions; said diffusion regions having partially overlying polysilicon landing sites to form N-type and P-type transistors;

wherein the regions are relatively-sized to form two distinct transistor sizes, smaller N- and P-type transistors and larger N- and P-type transistors.

- 1 14. The method of claim 13, wherein said semiconductor substrate comprises a silicon substrate.
  - 15. The method of claim 14, wherein processing said silicon substrate to form a gate array architecture comprises:

forming said partially overlying polysilicon landings so that said landings for the smaller and larger transistors are not connected.

- 16. The method of claim 15, wherein the ratio between the two distinct transistor sizes is on the order of one-third.
- 17. The method of claim 16, wherein the ratio between the capacitance of the larger and smaller relatively sized transistors is on the order of one-third.
- 18. The method of claim 15, and further comprising: forming a metallization interconnect overlying said gate array architecture.
- 19. The method of claim 18, wherein forming a metallization interconnect comprises forming a metallization interconnect that connects the transistors of the gate array architecture to form a
- 3 flip-flop.
- 1 20. The method of claim 19, wherein forming a metallization interconnect comprises forming
- an interconnect that connects the transistors of the gate array architecture so that the internal
- 3 clock buffers of the flip-flop are formed from the smaller transistors.
- 1 21. An article comprising: a storage medium said storage medium having instructions stored
- thereon, said instructions, when executed, resulting in the capability to design the layout of an
- 3 integrated circuit chip for fabrication, the integrated circuit chip including a gate array architecture,
- 4 the gate array architecture comprising a plurality of N-type diffusion regions and P-type diffusion
- 5 regions; said diffusion regions having partially overlying polysilicon landing sites to form N-type
- 6 and P-type transistors;
- wherein the regions are relatively-sized to form two distinct transistor sizes, smaller N- and
  P-type transistors and larger N- and P-type transistors.

- 1 22. The article of claim 21, wherein said instructions, when executed, result in the capability to
- design the layout of the gate array architecture, wherein the ratio between the two distinct
- 3 transistor sizes is on the order of one-third.
- 1 23. The article of claim 22, wherein said instructions, when executed, result in the capability to
- design the layout of the gate array architecture, wherein said partially overlying polysilicon
- 3 landings for the smaller and larger transistors are not connected.
- 1 24. The article of claim 23, wherein said instructions, when executed, result in the capability to
- design the layout of a metallization interconnect overlying said gate array architecture.
- 1 25. The article of claim 24, wherein said instructions, when executed, result in the capability to
- design the layout of a metallization interconnect overlying said gate array architecture, wherein said metallization interconnect couples the transistors of the gate array architecture to form a flip-

flop.

26. The article of claim 25, wherein said instructions, when executed, result in the capability to design the layout of a metallization interconnect overlying said gate array architecture that connects the transistors of the gate array architecture so that the internal clock buffers of the flip-flop are formed from the smaller transistors.

